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Stacie Hibino, Elke A. Rundensteiner

November 1997 **Proceedings of the fifth ACM international conference on Multimedia**

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Keywords: dynamic queries, temporal query filters, temporal visual query language, user interface evaluation

2 MMVIS: design and implementation of a multimedia visual information seeking environment



Stacie Hibino, Elke A. Rundensteiner

February 1997 **Proceedings of the fourth ACM international conference on Multimedia**

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Keywords: interactive visualizations, multimedia system design, temporal visual query language, video analysis

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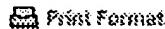
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